In the United States Patent and Trademark Office

In re the application of

Lee D. Whetsel

Serial No.: 09/845,562

Filed: 4/30/2001

Title: IC WITH DUAL PROTOCOL CONTROL TERMINAL

January 5, 2006

Asst. Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313

Dear Sir:

MAILING CERTIFICATE UNDER 37 C.F.R. §1.8(A)

I hereby certify that the above correspondence is being deposited with the U.S. Postal Service as First Class Mail in an envelope addressed to: Assistant Commissioner for Patents, P.O. Box 1450, Alexandria, VAJ 22313-1450 on January 5, 2086.

Lawrence J. Bassuk, Reg. No. 29,043

TI-31206

Art Unit: 2133

Examiner: P. Chung

Transmitted herewith is an amendment in this application.

The fee has been calculated as shown below.

CLAIMS AS AMENDED						
	CLAIMS REMAINING AFTER AMENDMENT		HIGHEST NUMBER PREVIOUSLY PAID FOR	PRESENT EXTRA	RATE	ADDITIONAL FEE
Total Claims	5	Minus	20	= 0	x \$50 =	\$ 0
Ind. Claims	1	Minus	6	= 0	x\$200 =	\$ 0
TOTAL ADDITIONAL FEE FOR THIS AMOUNT						\$ 0

Under 37 C.F.R. § 1.16(k) please charge the total additional fee, and any further fees, or credit overpayment to Deposit Account No. 20-0668, of Texas Instruments Incorporated.

espectfully submitted

Lawrence J. Bassuk

Reg. No. 29,043

Attorney for Applicant

Texas Instruments Incorporated P.O. Box 655474, M/S 3999 Dallas, Texas 75265 (972) 917-4418

the United States Patent and Trademark Office

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Amendment C Under 37 CFR 1.111

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Lawrence J. Bassuk, Reg. No. 29,043

Responsive to the Examiner's Action of 07/12/2005, please amend this application as follows:

In the Title:

Amend the title as follows:

IC WITH DUAL PROTOCOL CONTROL TERMINAL Process of Selecting Alternative Test Circuitry Within An IC